FCAL Collaboration Meeting @ Institute of Nuclear Physics Polish Academy of Sciences (IFJ PAN)



Contribution ID: 37 Type: not specified

The development of the readout ASICfor the pair-monitor with SOI technology - irradiation test

Tuesday 13 April 2010 09:20 (20 minutes)

Presenter: Y. SATO

Session Classification: Session 4. ADC + DAQ and FCAL sensors (silicon, diamond, GaAs, sapphire):

tests and developments